

<b>Notice of References Cited</b>	Application/Control No. 10/659,271	Applicant(s)/Patent Under Reexamination YAGUCHI ET AL.	
	Examiner John L. Goodrow	Art Unit 1756	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,677,093	01-2004	Yoshino et al.	430/106.2
*	B	US-6,130,017	10-2000	Hayashi et al.	430/108.3
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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